

# Machine Learning Approach to Transform Scattering Parameters to Complex Permittivity

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## Abstract:

This study investigates the application of an artificial neural network to predict the complex dielectric properties of granular catalysts commonly used in microwave reaction chemistry. The study utilizes finite element electromagnetic simulations and two-dimensional convolutional neural networks to solve for a large solution space of varying dielectrics. This convolutional neural network was trained using a supervised learning approach and a common backpropagation. The frequency range of interest was between 0.1 – 13.5 GHz with the real part of the dielectric constants ranging from 1 – 100 and the imaginary part ranging from 0 – 0.2. The network was double validated using experimental data collected from a coaxial airline. The model was demonstrated to convert either experimental or computational derived scattering parameters to complex permittivities.

Keywords: Dielectrics, Permittivity, GHz, Machine Learning, Convolutional Neural Networks

## Introduction

With recent advances in dielectrics and their synthesis techniques, there has been a need to increase the fidelity of inverse models to predict the dielectric properties of materials based on a measurable observable. In most cases and in the case of this study, these observables are scattering parameters derived from coaxial transmission line testing of the dielectrics. Having confidence in the measurement of a material's dielectric properties is important for fundamental device design in the fields of microwave engineering. It is hypothesized that a machine learning (ML) approach could be designed for transforming scattering parameter derived from experimental measurements to permittivity properties for the entire range of dielectrics materials, providing a general model. This research will rely on the use of electromagnetic computational solutions to generate synthetic data to train the ML model.

At GHz frequencies, the electromagnetic (EM) interactions are quantized by a material's dielectric properties or the dynamics of dipole interactions. The dielectric constant of a material is the ability of the material to store electrical energy. While the loss tangent of a material is a quantification of the energy loss. The complex dielectric is defined as  $\epsilon_r = \epsilon' - i\epsilon''$ , where  $\epsilon'$  is the real portion and  $\epsilon''$  is the imaginary portion. For microwave material engineering, the characterization of material dielectrics as a function of frequency and temperature are critical to understanding the response. Dielectric properties can often be difficult to ascertain for granular materials as the shape and distribution influence the polarizability and subsequently the dielectric response (Zangwill 2013)(Bussey 1967).

To date, the characterization of these properties has been done using a multitude of inverse mathematical techniques. Many of the techniques require initial guesses to avoid discontinuities arising from the resonance of the system (Nicolson & Ross 1970; Blakney & Weir 1975; Yaw 2006). Schwab et al. have recently shown what a powerful tool that machine learning can be for solving inverse problems using

latent information in high dimensions (Schwab et al. 2019). Recent computational advancements in the ability to conduct large numbers of permutations of solutions with high accuracy have ushered in the potential to revisit many of these inverse methods using a machine learning approach. By utilizing the inverse space of a problem Sahoo et al. showed that machine learning could be used to understand functional relationships between data to extract underlying equations showing great agreement with the paper published by Schwab et al (Sahoo et al. 2018). Moreover, Zhao et al. showed that machine learning methods could be applied to a wide variety of microwave device modeling techniques, both of active and passive devices achieving efficient and fast characterization (Zhao et al. 2013).

The complexity of many dielectric materials such as in the case in microwave chemistry and the use of heterogeneous (multi-component, macroscopic, granular) catalysts leads to inaccuracies in dielectric constant calculations, stemming from non-standard synthesis procedural approach and therefore high dimensionality of inverse space. In Mueller et al.'s review of current machine learning approaches in materials they establish how supervised learning techniques like the one used in this paper have achieved excellent structure-property predictions (Mueller et al. 2016). The most direct method of determining an observable-property relationship, in the case of this study for the complex dielectric properties, are from calculations based on scattering parameters (S-parameters). Multiple measurement techniques utilize S-parameters, such as a rectangular free-space waveguide, open-ended probe, free space, resonant cavity, parallel plate and coaxial precision airline (Baker-Jarvis et al. 1992; Bois 1999; Geyer et al. 2005; Zangwill 2013). These different methods utilize different inverse techniques such as Nicholson-Ross-Weir (NRW), NRW polynomial, The National Institute of Standards and Technology (NIST) Iterative, NIST non-iterative, and the short circuit line (SCL) methods (Nicolson & Ross 1970; Yaw 2006; Bartley & Begley 2010). All these techniques suffer from intrinsic errors such as the need to de-embed the void space within each testing apparatus as well as mathematical discontinuities that must be eliminated or ignored.

Artificial neural networks (ANNs) and convolutional neural networks (CNN) are a subset of machine learning that lend themselves well to material science problems. The usage of these networks has been steadily on the rise over the past decade, with more and more studies investigating the possibilities of ANNs to map non-linear relationships (Nigrin 1993). ANNs are part of the biologically inspired computational techniques used in different artificial intelligence applications (Scott et al. 2007; Raff et al. 2012). ANNs have been used in many applications of chemistry, material science, and microwave engineering (Yasin et al. 2020; Raff et al. 2012). In Li et al.'s paper they proved that machine learning models are more accurate than traditional linear and non-linear statistical regression methods when dealing with high dimensional inputs (Li & Yuan 2017). This advantage of machine learning algorithms only increases as the dimensionality and non-linearity of the relationships increases (Guo et al. 2002; Agostinelli et al. 2015; Li et al. 2017).

Machine learning models and ANNs, in particular, have recently been used in the literature to try and relate complex geometric parameters or certain material characteristics to dielectric constants (Scott et al. 2007; - et al. 2013). However, Tuck and Coad (Tuck & Coad 1995) showed that ANNs can be used to calculate the dielectric properties of liquids directly from the S-parameters using a coaxial probe method without the need for de-embedding the data first. By calculating the dielectric properties directly from the recorded S-parameters without needing to de-embed the data in the time domain Tuck and Coad were able to achieve a significant reduction in the intrinsic error. This was because the ANN was able to capture the realities of the non-ideal system by training the ANN on vectors of reflected coefficient data

and correlating that to the permittivities of the substance being studied. This method avoided the need for any parametric models of the cable such as those used by Stuchly et al. in their attempt to solve the inverse problem (Gajda & Stuchly 1983).

Chen et al. (Chen et al. 2011) demonstrated that this same de-embedding approach was suited for different geometries. More importantly, Chen et al. were able to show that finite difference time-domain (FDTD) simulation data can be used to accurately train an ANN for prediction on experimental data. They even postulate that this method would work for granular materials and at high temperatures. These ANNs however, were limited in scope to only liquids due to both the computational restrictions of the time and method chosen to solve the inverse problem. The probe method that Tuck et al and Chen et al utilized only looks at the non-linear and complex relationships between a single observable, reflected coefficient of the scattering parameters ( $S_{11}$ ) and the dielectric properties. In more advanced measurement techniques utilizing different methods such as the coaxial airline, in which two observables,  $S_{11}$  and  $S_{22}$  are utilized it is believed more accurate results are possible. Regardless the results of both studies were fast and extremely accurate calculations of dielectric properties of a combination of different liquids.

This study investigates and implements a machine learning algorithm for the use of calculating the dielectric properties of solid materials in a coaxial airline using the observable parameters  $S_{11}$  and  $S_{21}$ . This approach like Tuck and Coad's will allow for the calculation of the dielectric material to take place directly from the measured S-parameters without the need to de-embed the air in the coaxial airline. Thus, simplifying the mathematics and intrinsic error. The approach is to use supervised learning to teach and validate an algorithm using simulated S-parameters and dielectric data. The advances in modern computational power allow for high fidelity simulated data for almost all feasible combinations of this observable-property relationship.

Once trained the CNN model is validated on experimentally collected S-parameters for known dielectric materials. This approach was selected because of the precise control of the input and outputs being used in training the system and its reproducibility as well as its ability to capture a large portion of the solution space. The system attempts to achieve increased accuracy over previous models by utilizing the additional input parameters available when testing in the coaxial airline. The previous studies were only able to utilize the reflected coefficient of the S-parameters ( $S_{11}$ ) because of the limitations of the coaxial probe method. The coaxial airline method provides both the forward and reflected coefficients of the S-parameters ( $S_{11}$  and  $S_{21}$ ).

The methodology for this study is to generate simulation solutions for a wide variety of dielectrics. In addition to varying the dielectric properties in the simulation, the specimen length within the coaxial line was also varied. It is postulated that for any sample length and dielectric constant there exists a unique set of inputs (S-parameters) that generate that solution for a given testing geometry. This would allow the ANN method to be length invariant, a considerable advantage over the precise length measurements needed by some of the classical measuring techniques. By teaching a machine learning algorithm these relationships based on multiple conversion methods a more robust and accurate solution can be obtained than previously existed. Utilizing the simulation results with machine learning can potentially result in a much faster and less computationally intensive solution methodology. Together these techniques can provide a new solution method for converting S-parameters to dielectric properties.

## 1. Classic Measurement Methods

The most common conversion model for S-parameters to dielectric properties is the NRW method as it gives information on both the electric and magnetic properties of a material. The NRW provides a direct calculation of the dielectric properties from the S-parameters. This method utilizes the  $S_{11}$  and  $S_{21}$  parameters which are the amplitude and ratio of the electric field that is reflected and passed through a material respectively (Yaw 2006). It is a very robust method that can solve for the dielectric properties of many different types of materials. The popular Keysight vector network analyzer utilizes this approach as the standard option when calculation dielectric properties. However, the main drawback to this method is that the solution diverges at frequencies of integer multiples of  $\frac{1}{2}$  wavelength for low loss materials. This leads to this method performing better with shorter samples (Nicolson & Ross 1970; Blakney et al. 1974).

Another extensively used method in literature is the NRW polynomial method, this method takes the NRW conversion method and fits a polynomial to the dielectric properties. This eliminates the discontinuity peaks at  $\frac{1}{2}$  wavelength but turns the entire solution into a close approximation rather than a high precision measurement (Bartley & Begley 2010). NIST iterative conversation method is another method for calculating the dielectric properties that utilize the Newton-Raphson's root finding method to calculate the dielectric properties. This method avoids the discontinuities that happen when using the NRW method by requiring a good initial guess and is good for long samples and low loss materials (Yaw 2006). Without a good initial estimate, the solution will diverge and/or be highly inaccurate. The NIST iterative method also assumes that permeability is equal to unity making it applicable for only nonmagnetic materials (Geyer et al. 2005).

The other NIST method is a non-iterative method that closely resembles the NRW method but assumes the permeability is equal to unity. Unlike many of the other methods, there are no sample length criteria for this method any arbitrary sample length is acceptable (Yaw 2006). The biggest drawback to this method is the smaller scope of materials it can measure because of the non-magnetic assumptions (Geyer et al. 2005). A unique measurement method among transmission line measurements of S-parameters is the SCL method. Calculations are performed using only the  $S_{11}$  parameter and accurate sample positional information to calculate the complex dielectric properties of a material. The SCL method uses Newton-Raphson's numeric approach to calculate dielectric properties. The simplicity of the inputs for this method makes it suited for broadband measurements and long samples with low loss. Like all the methods but the NRW methods the SCL method also assumes a permeability equal to one (Yaw 2006).

## 2. Computational Details

### 2.1 Material Dataset Generation

The calculations from S-parameters for varying dielectric properties were determined using a finite element (FE) EM wave modeling software COMSOL Multiphysics® (COMSOL AB). All solutions were solved in the frequency domain, using the finite element frequency domain (FEFD) approach. While it is beyond the scope of this study to elaborate on the advantages of FEFD method over an FDTD method, the advantage is two-fold. First, the FE approach is an implicit technique that relies on a energy minimization method while the FD involves a explicit stability criterion dependent on the mesh characteristics. Second, by solving in the frequency domain the computational time is significantly reduced by eliminating time-stepping criteria. While these advantages do not apply to all problems,

especially large (time and spatial) non-linear problems, the frequency domain was appropriate for the following 2D axis-symmetric linear (steady state, non-temperature dependent properties) study.

Using the FEFD model a series of parametric sweeps of both the real and imaginary portions of the dielectric properties was performed to encompass most naturally occurring dielectric materials. Properties were swept from a real dielectric constant of 1 to 100 in increments of 0.5 while the imaginary portion of the dielectric properties were varied from 0 to 2 in increments of 0.05. These parametric sweeps were done in conjunction with a gradually increasing sample length. The length of the sample was increased from an initial 10 mm to 50 mm in 1 mm increments. These dielectric properties were evaluated in correspondence with a frequency range of 0.1 to 13.5 GHz at 51 equally spaced points. The computational model was set up to represent a real world two-port vector network analyzer by means of a high precision coaxial airline of length 150 mm. The airline is modeled based on the experimental airline used for validation. The coaxial airline is an HP model no. 85051-60010 with a 0.70 cm diameter.

A 2D axis-symmetric FE model was constructed, which represented the 150mm coaxial airline that is used in the experimental measurement setup. Figure 1 is an illustration of the coaxial airline modeled with the FE solver software. The walls of the airline, as well as the center electrode, were assumed to be perfect electrical conductors. Due to the axis-symmetric assumption, it is assumed only a 2D representation of a slice in the +r and +z directions needed to be constructed. The plane was partitioned at an initial  $z=10$  mm to form two material regions increasing after each full parametric sweep. The region between  $z=0$  mm and  $z=10$ -50 mm will be defined as the sample region. The remaining will be assigned air (vacuum,  $\epsilon_r=\mu_r=1$ ). Two ports were defined at extremes in the z-dir. Port 1 was defined at  $z=150$  mm and Port 2 was defined at  $z=0$  mm. A coaxial boundary condition (TEM mode) was specified for both ports. The scattering parameter was measured at both port planes without the de-embedding of the void air space, as would be representative of experimental measurement where de-embedding has taken place during the calculation of the dielectric properties from the S-parameters observed at the ports. Figure 1B is a contour plot of the radial electric field ( $E_r$ ) at 13 GHz and 1W of input power at Port 1. For the remainder of the study, 0.1W will be used as the input power with the understanding that 1) material properties are linear and are not changed by field strength or temperature, 2) scattering parameters are a function of normalized power, and 3) the experimental network analyzer will utilize much lower port power. The color contours of Figure 1B and the inset image confirm the radial electric field is synonymous with a TEM mode.

## 2.2 Artificial Neural Network Implementation

The ANN was developed using open-source TensorFlow developed by Google in python for ease of implementation with all data scaled to be within the same power factor. The ANN used two different approaches one in which all 5 input features of, frequency, the magnitude of  $S_{11}$  and  $S_{21}$ , and the phase in radians of  $S_{11}$  and  $S_{21}$  were studied independently of one another. This first approach would allow for researchers to get discrete answers at any frequency point independent of the solutions to previous frequencies. The other approach was to look at all the inputs for a given dielectric at once, in this case, all 51 data points from 0.1 to 13.5 GHz. This second approach attempts to pull the latent information that exists in the transition between wavelengths to achieve a better characterization across the whole frequency range. The data was broken down into 3 different sets 60% was allocated to training data, 20% to validation data, and 20% to test data. With the experimental data being kept separate until a suitable algorithm had been created. This breakdown allows the algorithm to be tested on unseen data ensuring

that it was not overfitted to the training and validation data before it was tested on experimental data. To achieve the ideal performance of this network multiple different loss functions were looked at as well as different combinations of the number of neurons and number of hidden layers. Different regularizers were investigated to help encourage convergence. These different combinations were evaluated using the mean squared error (MSE) and the mean absolute error (MAE).

To ensure optimization of these parameters the ANN utilized the ReLU activation function and the Adadelta optimizer. The network also introduced Gaussian noise into the training data to represent real world errors in experimental setups. The ReLU activation function was chosen because of its proven ability to represent sparsity (Li & Yuan 2017; Ramachandran et al. 2017). Sparsity is useful in ANN because of its ability to imitate a biological neural network. Sparsity in an ANN allows for models to have better predictive power with less noise and overfitting by encouraging neurons to only process meaningful aspects of the problem (Agostinelli et al. 2015; Ramachandran et al. 2017). In the work by Maas et al. (Maas et al. 2013) and Narang et al. (Narang et al. 2017), they demonstrated that increased sparsity helped to improve an ANNs training performance and reduce computational time for several problems.

The Adadelta optimizer is a gradient descent method that utilizes a dynamic updating system. The system adapts using first-order information and stochastic gradient descent which reduces its computational cost over many of the other optimizers available (Zeiler 2012). One of the key advantages of this optimizer for the ANN system of interest is that it requires no human training of the learning rate and can handle training data that may have lower signal to noise ratios. These two hyperparameters were chosen after some initial data testing and held constant for the remainder of the study. The first scheme when considering frequency points independently employed, two convolutional layers, and two fully connected layers. The second scheme in which an array of frequency points is used employed, two convolutional layers, one max pooling layer, and two fully connected layers.

### 2.3 Experimental Data Collection Method

Data was collected on a Teflon (PTFE) plug, replicating the standard NRW test that validated their measurement model. To take a measurement the sample was loaded into the airline with the center electrode in place, as shown in Figure 2A. All interfaces between the airline and cables were thoroughly cleaned using isopropyl alcohol and dried using dry compressed air. Each test was conducted with a frequency range from 0.1 to 13.5 GHz. The scattering parameters were recorded at 51 equally spaced points within this range. The relative dielectric constant for each point was calculated using the NRW method. All measurements reported in the study were conducted using a 0.70 cm diameter coaxial airline (HP model no. 85051-60010), as shown in Figure 2A, and connected to a Keysight N5231A PNA-L microwave network analyzer shown in Figure 2B.

## 3. Results and Discussion

### 3.1 Correlation Analysis Method

The simulation derived dielectric datasets consisted of several million values with real portions of the dielectric constant ( $\epsilon'$ ) ranging from 1 to 100 and the imaginary portion of the dielectric constant ( $\epsilon''$ ) ranging from 0 to 2. The corresponding inputs of S-parameters include the magnitude and phase of S11 and S21. Because the system is symmetric S11=S22 and S21=S12 and therefore only S11 and S21 are necessary. To create an efficient and accurate machine learning model a statistical analysis of the input features needed to be performed to determine their significance on output targets. Strong correlations

can be both good and bad for ANNs, strong correlations can help to reduce the number of input features needed for the network. However, these correlations can also skew the network towards harmful bias creating multicollinearity with a single input and the target feature. Resulting in small changes to the input data leading to large changes in the model output. To check on these traits a Pearson correlation was performed between all the input features and the output targets (Mittlböck & Schemper 1996). Table 1 is a summary of the correlation between the inputs and outputs. With a 1.0 meaning a very strong positive correlation and a -1.0 corresponding to an inversely related correlation. The scattering parameter magnitude is denoted as  $|S_{11}|$  and  $|S_{21}|$ . The associated phase angle of the scattering parameter is denoted as  $\angle S_{11}$  and  $\angle S_{21}$ .

As seen in Table 1 the magnitudes of  $S_{11}$  and  $S_{21}$  are strongly correlated to the real part of the dielectric constant. The features that correlate linearly to a dielectric constant are the magnitude of the wave that is reflected from a material and magnitude of the same wave that passes through the material. This correlation of magnitudes is expected since the real part of the dielectric constant is the ability of a material to store energy. It is noted from Table 1 that there is no linear correlation between the phase angle and the magnitude of scattering parameters. There is also a lack of correlation between the phase angle and the dielectric constant. While this is correct for the assumed linear materials and constant sample geometry (plug length) some caution must be taken with this correlation. If the phase angles of the scattering parameters were eliminated it would make this system highly linearly correlated to the magnitude of the scattering parameters. This would result in poor system performance as small changes in the magnitude of the scattering parameters would have larger effects on the output of the system (dielectric properties). CNN's are uniquely suited to this type of problem because not only do they perform their calculations in high dimensionality, but they use convolutional math applied over the input data. Therefore, the inclusion of the phase angle allows the network to eliminate its dependence on the magnitude of the scattering parameters as seen in other multi-layer perceptron networks.

To achieve a more extensive understanding of the different relationships between input features and output targets joint plots were created for each input. These are shown in Figure 3A-D where the entire spectrum of dielectric properties as a function of the inputs. The darker regions of the contour plot representing a stronger correlation. From these plots, a better understanding of the correlation coefficient from Table 1 can be gained. The strong positive and negative correlation for the magnitudes of  $S_{11}$  and  $S_{21}$  can be seen in Figures 3a and 3b. However, the figure illustrates that there is a direct effect on correlation based on the magnitude of the dielectric properties ( $|S_{11}|$  and  $|S_{21}|$ ). Lower dielectric constants ( $\epsilon' < 20$ ) express little to no correlation between the input parameters and the output. While high dielectric constants ( $> 40$ ) show an increasingly strong correlation between the inputs and the output as the dielectric constant approaches 100. This growing correlation will provide a unique challenge to the design of the ANN architecture as traditional approaches to strong and weak correlation architecture will be insufficient to capture the unique relationship. It can be seen from Figure 3C and 3D that while a Pearson coefficient of zero indicated no relationship between phase and the imaginary portion of the dielectric, there does in fact exist regions in which these two parameters are correlated.

## 4. Results

### 6.1 ANN Results

The trained neural network was used to predict on randomly generated test data that the ANN was not explicitly trained or validated on. Multiple models with a varying number of convolutional layers,

hidden layers, neurons, and loss metrics were evaluated for their applicability in the calculation of the complex dielectric properties. Each test was run for 500 epochs to allow for convergence to an optimized set of weights and used the Relu activation function along with the adadelata optimizer. The training set used in the network had a mean dielectric constant of 50.4 and a standard deviation of 28.6 while the test set had a mean of 50.8 and a standard deviation of 28.7. This similarity confirms that the test datasets contains a good representation of the whole dataset. Demonstrating that the data was well randomized and ANN performance was not due to the selection of a certain sub-dataset.

Considering the first approach where each frequency point is considered independently, Figure 4A is a plot of the results of the CNN outputs for the dielectric constant plotted against the actual dielectric constant recorded from COMSOL. The statistical results of the network showed an MSE of 0.25 and a MAE of only 0.36, meaning that there were no range of dielectrics or parts of the frequency spectrum that the network could not learn. The network was also able to achieve an MSE and MAE of 0.001 and 0.03 respectively on the imaginary portion of the dielectric. It is noted however, that as dielectric constant increases there exist a larger divergence of the predicted values against that of the actual values.

A comparison between Figure 4A and Figure 3A and B illustrates this, due to the adverse relationship between how strongly input and output features are correlated, the predictive accuracy of the ANN starts to degrade because of an increase in multicollinearity. As dielectric constant approaches, 100, and the correlation between the magnitudes of S11 and S21 show a much stronger relationship the predictive accuracy of the ANN goes down due to the strong dependence on a single input parameter. This multicollinearity is unfavorable at high dielectric constants where variables can be linearly predicted from the others with a high degree of accuracy resulting in erratic responses to small changes. The strong correlation skews the values of predictions with small changes in the weight resulting in larger responses in the output neurons. At smaller dielectric constants were the predictive accuracy of the ANN is much greater showing little scattering from the regression line.

The second approach results where the entire frequency spectrum is used as an input to the CNN are shown in Figure 4B. As with the results shown in Figure 4A, the network can accurately predict the dielectric constant for all values looked at in this study. However, a comparison of Subfigures 4A and 4B confirms that this second approach has a much smaller spread of predictions, especially at high dielectrics. Statistically, the results between these two approaches are very similar to this approach having an MSE of 0.430 and an MAE of 0.511 for the real portion of the dielectric. While the imaginary portion had an MSE of 0.002 and MAE of 0.035. It can be seen that the second approach while limited to frequency independent dielectrics results in a higher accuracy across a wider range of dielectrics.

## 6.2 Experimental Data Results

To validate that the ANN architecture that was selected could be used in future applications experimentally collected data needed to be tested on it. This was accomplished using a Teflon piece of 44.45 mm in length and machined to fit the high precision coaxial airline. The validation metrics used previously in this study were performed on the dielectric constant of the Teflon piece as well as other dielectric properties such as the loss tangent. The scattering parameters from the Teflon piece were evaluated using the different CNN approaches. The pre-trained ANN was loaded into python as a json file with the weights saved as an h5 file. The Teflon's scattering parameters were evaluated over the frequency range and compared to the NRW results for evaluation. The performance of ANN at predicting the dielectric constant and the loss tangent of the Teflon is shown in Table 2, once again the system was



evaluated using the MSE and MAE. The equation for loss tangent is shown in Equation 1, epsilons are the associated components of the complex dielectric.

$$\tan(\delta) = \frac{\epsilon''}{\epsilon'} \quad \text{Eq. (1)}$$

## 5. Conclusions and Recommendations

A machine learning ANN has been designed that predicts the dielectric properties of any material inside of coaxial airline geometry using only the standard inputs of S11 and S21. With either method discussed in this paper showing excellent results. The system showed exceptional performance on training datasets and experimentally collected datasets. Input data required very little preprocessing, with scaling being the only numeric manipulation done to the datasets. This study shows that with a high-fidelity model of a given geometry an ANN can be created on computational data that will allow the prediction of dielectric properties without the need to de-embed air. It should be noted that as the dielectric constant increased the ANN had a harder time predicting. This problem could be eliminated using a filtering system with multiple downstream neural networks that train on smaller ranges of data to increase accuracy within ranges of interest.

As part of a larger project, the ANN developed here can help to form a vital link between in-situ reactions in the microwave regime and real-time characterization of EM wave material interactions. The methodology can be extremely helpful in characterizing things such as microwave catalysts in real-time to further the study of catalytic materials.

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## 7. Disclosure Statement

No potential conflict of interest was reported by the authors.

- Zhao Z, Qu Y, Zhang Y, Shen X. 2013. Overview of Microwave Device Modeling Techniques Based on Machine Learning. *Int J Adv Comput Technol*. 5(9):299–306.
- Agostinelli F, Hoffman M, Sadowski P, Baldi P. 2015. Learning Activation Functions to Improve Deep Neural Networks. In: 3rd Int Conf Learn Represent ICLR 2015 - Work Track Proc. San Diego: ICLR 2015; p. 1–9.
- Baker-Jarvis J, Janezic MD, Grosvenor Jr JH, Geyer RG. 1992. Transmission/Reflection and Short-Circuit Line Methods for Measuring Permittivity and Permeability. OFFICE USGP, editor. Washington D.C.
- Bartley PG, Begley SB. 2010. A new technique for the determination of the complex permittivity and permeability of materials. In: IEEE Instrum Meas Technol Conf. Austin, TX, USA.
- Blakney TL, Weir WB. 1975. Automatic Measurement of Complex Dielectric Constant and Permeability at Microwave Frequencies. *Proc IEEE*. 63(1):203–205.
- Blakney TL, Weir WB, Constant D. 1974. Comments on “Automatic Measurement of Complex Dielectric Constant and Permeability at Microwave Frequencies.” *Proc IEEE*. 63(1):203–205.
- Bois KJ. 1999. Analysis of an Open-Ended Coaxial Probe with Lift-off for Nondestructive Testing. *IEEE Trans Instrum Meas*. 48(6):1141–1148.
- Bussey HE. 1967. Measurement of RF Properties of Materials A Survey. *Proc IEEE*. 55(6):1046–1053.
- Chen Q, Huang K-M, Yang X, Luo M, Zhu H. 2011. AN ARTIFICIAL NERVE NETWORK REALIZATION IN THE MEASUREMENT OF MATERIAL PERMITTIVITY. *Prog Electromagn Res*. 116(April):347–361.
- COMSOL AB. EM Module [Internet]. [www.comsol.com](http://www.comsol.com)
- Gajda G, Stuchly SS. 1983. An Equivalent Circuit of an Open-Ended Coaxial Line. *IEEE Trans Instrum MEASUREMENT*. 32(4):367–368.
- Geyer RG, Grosvenor CA, Holloway CL, Janezic MD, Johk RT, Kabos P, Baker-Jarvis J. 2005. Measuring the permittivity and permeability of lossy materials : Boulder.
- Guo D, Wang Y, Xia J, Nan C, Li L. 2002. Investigation of BaTiO<sub>3</sub> formulation: An artificial neural network (ANN) method. *J Eur Ceram Soc*. 22(11):1867–1872.
- Li Y, Yuan Y. 2017. Convergence Analysis of Two-layer Neural Networks with ReLU Activation. In: Adv Neural Inf Process Syst 30. Long Beach: NeurIPS Proceedings; p. 1–11.
- Li Z, Ma X, Xin H. 2017. Feature engineering of machine-learning chemisorption models for catalyst design. *Catal Today* [Internet]. 280:232–238. <http://dx.doi.org/10.1016/j.cattod.2016.04.013>
- Maas AL, Hannun AY, Ng AY. 2013. Rectifier Nonlinearities Improve Neural Network Acoustic Models. *Proc 30 th Int Conf Mach Learn*. 30(1):3.
- Mittlböck M, Schemper M. 1996. Explained variation for logistic regression. *Stat Med*. 15(19):1987–1997.
- Mueller T, Kusne A, Ramprasad R. 2016. Science : Recent Progress. *Rev Comput Chem*. 29(i).
- Narang S, Elsen E, Diamos G, Sengupta S. 2017. Exploring Sparsity in Recurrent Neural Networks. *Int Conf Learn Represent*. 1(1):1–10.

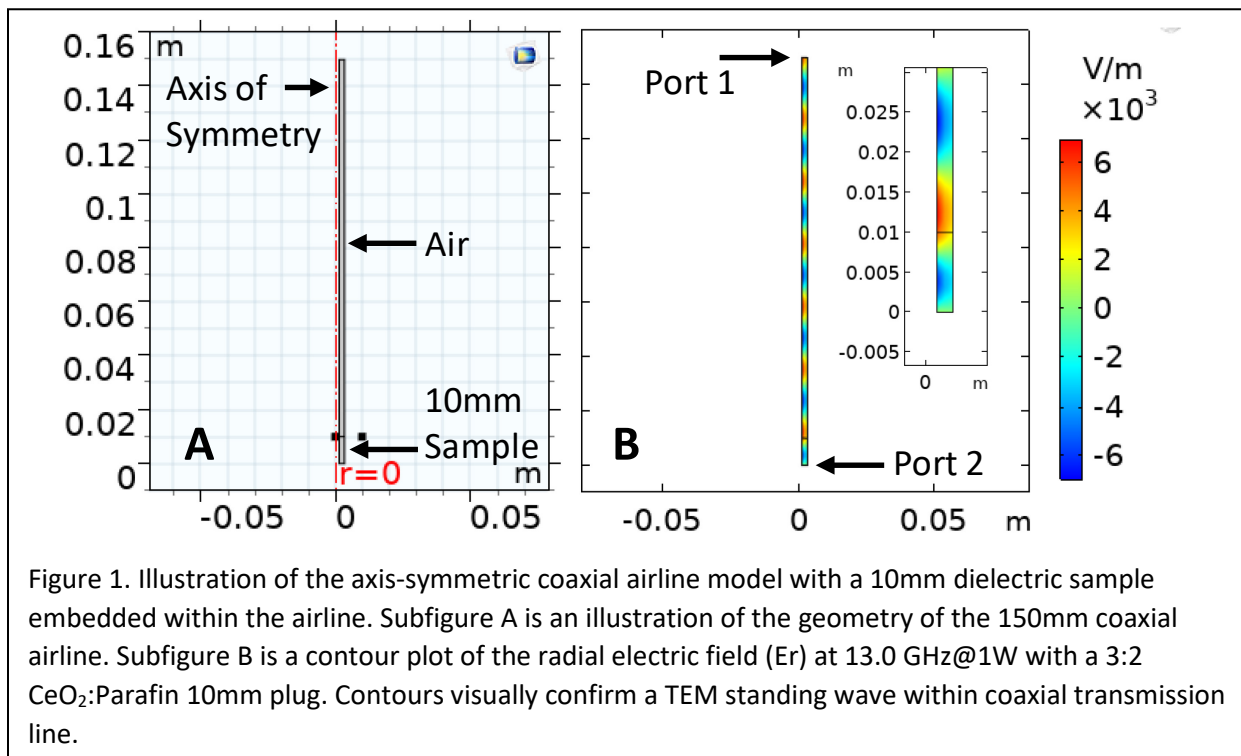
- Nicolson AM, Ross GF. 1970. Measurement of the Intrinsic Properties of Materials by Time Domain Techniques. *IEEE Trans Instrum Meas.* 19(4):377–382.
- Nigrin A. 1993. *Neural networks for pattern recognition*. 1st ed. Massachusetts: MIT Press.
- Raff L, Komanduri R, Hagan M, Bukkapatnam S. 2012. Applications of Neural Network Fitting of Potential -Energy Surfaces. In: *Neural Networks Chem React Dyn*. Oxford: Oxford University Press; p. 283.
- Ramachandran P, Zoph B, Le Q V. 2017. Searching for Activation Functions. *arXiv.* 1(1):1–13.
- Sahoo S, Lampert C, Martius G. 2018. Learning Equations for Extrapolation and Control. *Proc 35th Int Conf Mach Learn.* 80:4442–4450.
- Schwab J, Antholzer S, Haltmeier M. 2019. Deep null space learning for inverse problems: Convergence analysis and rates. *Inverse Probl.* 35(2).
- Scott DJ, Coveney P V., Kilner JA, Rossiny JCH, Alford NMN. 2007. Prediction of the functional properties of ceramic materials from composition using artificial neural networks. *J Eur Ceram Soc.* 27(16):4425–4435.
- Tuck D, Coad S. 1995. Neurocomputed Model of Open-Circuited Coaxial Probes. *Ind Res.* 5(4):5–7.
- Yaw KC. 2006. Measurement of dielectric material properties Application Note, Rohde & Schwarz. *Meas Tech.:*1–35.
- Yasin AS, Musho TD. A machine learning approach for increased throughput of density functional theory substitutional alloy studies. *Computational Materials Science.* 2020 Aug 1(181):109726.
- Zangwill A. 2013. *Modern electrodynamics*. Cambridge: Cambridge University Press.
- Zeiler MD. 2012. ADADELTA: An Adaptive Learning Rate Method. *arXiv.* 1(1):1–6.
- Zhao Z, Qu Y, Zhang Y, Shen X. 2013. Overview of Microwave Device Modeling Techniques Based on Machine Learning. *Int J Adv Comput Technol.* 5(9):299–306.

	<b> S11 </b>	<b> S21 </b>	<b>∠S11</b>	<b>∠S21</b>	<b>ε'</b>	<b>ε''</b>
<b> S11  (Input)</b>	1.0	---	---	---	---	---
<b> S21  (Input)</b>	-0.9	1.0	---	---	---	---
<b>∠S11 (Input)</b>	0.0	0.0	1.0	---	---	---
<b>∠S21 (Input)</b>	0.0	0.0	0.0	1.0	---	---
<b>ε' (Output)</b>	0.8	-0.9	0.0	0.0	1.0	---
<b>ε'' (Output)</b>	0.0	-0.2	0.0	0.0	0.0	1.0

Table 1. Correlation matrix for input and output parameters. Values range from -1 to 1. Negative values are associated with inverse correlation.

	MAE Model 1	MSE Model 1	MAE Model 2	MSE Model 2
$\epsilon'$	0.24	0.22	0.56	0.66
$\tan(\delta)$	0.19	0.16	0.59	0.64

Table 2. Comparison of the predicted dielectric properties with experimentally determined dielectric properties of Teflon. The experimental values are based on NRW method with  $\epsilon' = 2.16$  and loss tangent = 0.0007. MSE=mean squared error and MAE=mean absolute error. Model 1 is associated with the Figure 4A and Model 2 is associated with Figure 4B.



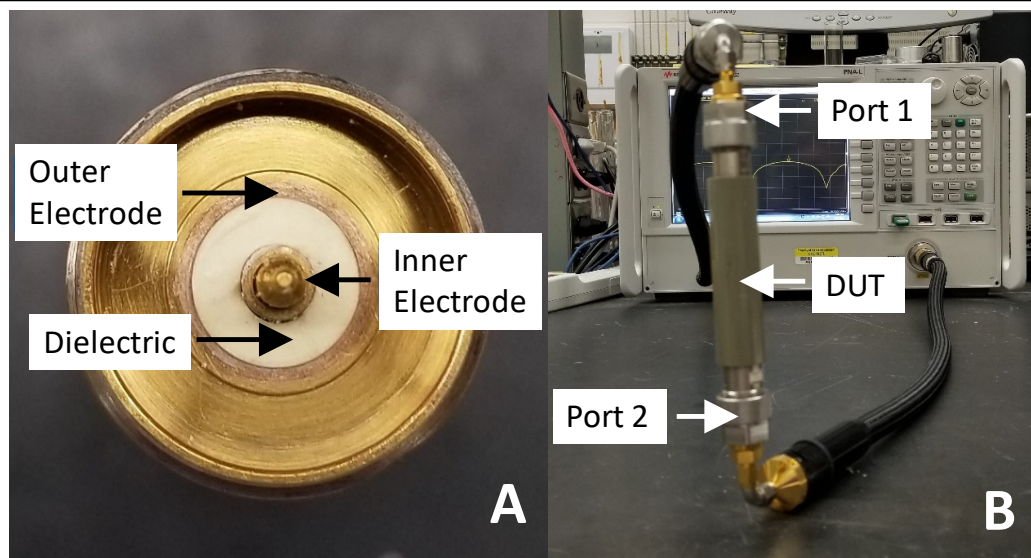


Figure 2. Photographs of the experimental coaxial airline and network analyzer. Subfigure A is a photograph normal to the port plane with a Teflon (dielectric) plug within the airline. Subfigure B is the coaxial airline connected to a network analyzer.

